Product data sheet

1. General description

WG75N120HFP1 uses advanced Fine Trench Field-stop IGBT technology with full current anti-parallel diode in TO247-Plus package. This device is part of the High-Speed series of IGBTs, which represents an optimum compromise between conduction and switching losses to maximize the efficiency of high switching frequency converter.



2. Features and benefits

- · Maximum junction temperature 175 °C
- · High-Speed switching series
- · Positive Temperature efficient for Easy Parallel Operating
- · Very soft, fast recovery full current anti-parallel diode
- · EMI Improved Design

3. Applications

- Solar inverter
- UPS
- · Welding converters
- PFC
- · Mid to high switching frequency applications

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter		Notes	Value			Unit
V _{CE}	Collector-emitter voltage, T _j ≥ 25 °C			1200		V	
I _c	DC collector current, limited by $T_{j(max)}$ $T_C = 100 ^{\circ}C$				75		Α
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	Static characteristics						
V _{CE(sat)}	Collector-emitter saturation voltage	$V_{GE} = 15 \text{ V}; I_C = 75 \text{ A}; T_j = 25 \text{ °C}$		-	1.7	2.2	V

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5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		•C
2	С	collector		
3	E	emitter		
mb	С	mounting base; connected to collector	1 2 3	G E sym200

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WG75N120HFP1	TO247P	WG75N120HFP1Q	Tube	30	TO247PA	09-Apr-2025

7. Marking

Table 4. Marking codes

Type number	Marking codes
WG75N120HFP1	75N120HF

8. Limiting values

Table 5. Limiting values

Symbol	Parameter	Notes	Value	Unit
V_{CE}	Collector-emitter voltage, T _j ≥ 25 °C		1200	V
I _C	DC collector current, limited by $T_{j(max)}$ T_{c} = 25 °C T_{c} = 100 °C		150 75	А
I _{C(puls)}	Pulsed collector current, t _p limited by T _{j(max)}		225	Α
-	Turn off safe operating area $V_{CE} \le 1200 \text{ V}, T_j \le 175 ^{\circ}\text{C}, t_p = 1 \mu\text{s}$		225	А
I _F	Diode forward current, limited by $T_{j(max)}$ $T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$		150 75	А
I _{Fpuls}	Diode pulsed current, t _p limited by T _{j(max)}		225	Α
V_{GE}	Gate-emitter voltage		±20	V
P _{tot}	Power dissipation $T_C = 25 ^{\circ}\text{C}$ Power dissipation $T_C = 100 ^{\circ}\text{C}$		1154 577	W
T _{stg}	Storage temperature		-55 to +150	°C
T _{jmax}	Maximum operating junction temperature		175	°C
-	Peak soldering temperture		260	°C

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
R _{th(j-c)}	IGBT thermal resistance from junction to case			-	0.13	-	K/W
R _{th(j-c)}	Diode thermal resistance from junction to case			-	0.35	-	K/W
R _{th(j-a)}	thermal resistance from junction to ambient			-	40	-	K/W

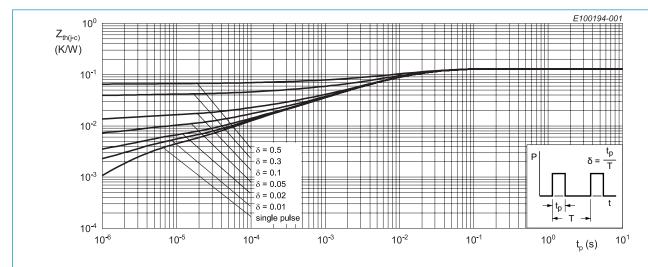


Fig. 1. Transient thermal impedance from junction to case as a function of pulse duration; IGBT

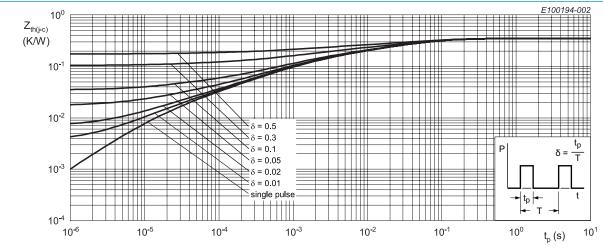


Fig. 2. Transient thermal impedance from junction to case as a function of pulse duration; Diode

10. Characteristics

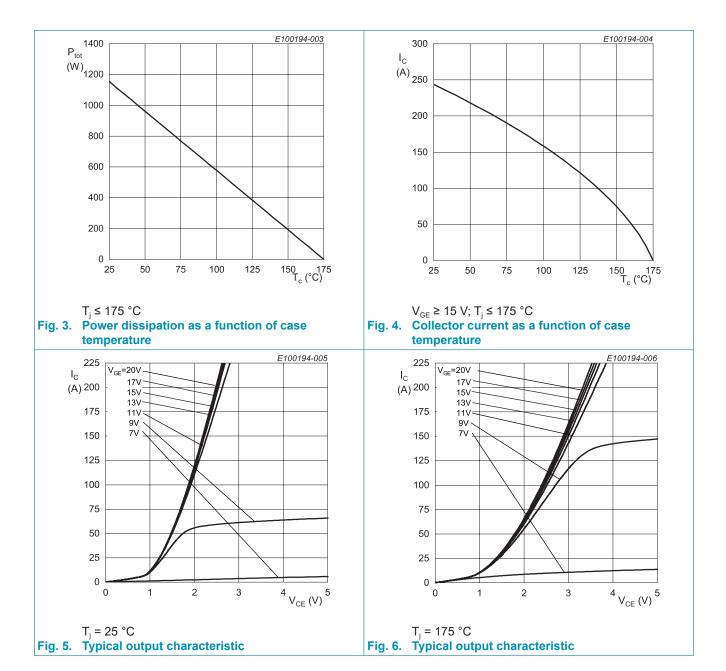
Table 7. Characteristics

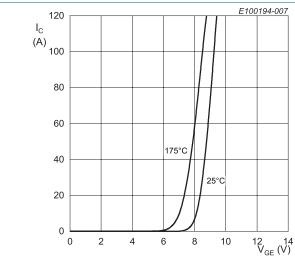
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	aracteristics			,		,	'
BV _{CES}	Collector-emitter breakdown voltage	$V_{GE} = 0 \text{ V; } I_{C} = 1 \text{ mA}$		1200	-	-	V
$V_{\text{CE(sat)}}$	Collector-emitter saturation	V_{GE} = 15 V; I_{C} = 75 A; T_{j} = 25 °C		-	1.7	2.2	V
	voltage	V _{GE} = 15 V; I _C = 75 A; T _j = 175 °C		-	2.2	-	V
V _F	Diode forward voltage	$V_{GE} = 0 \text{ V}; I_F = 75 \text{ A}; T_j = 25 \text{ °C}$		-	3.2	-	V
		V _{GE} = 0 V; I _F = 75 A; T _j = 175 °C		-	2.7	-	V
$V_{\text{GE(th)}}$	Gate-emitter threshold voltage	$I_{C} = 750 \ \mu A; \ V_{CE} = V_{GE}$		4.6	5.6	6.6	V
	Zero gate voltage collector	V _{CE} = 1200 V; V _{GE} = 0 V; T _j = 25 °C		-	-	250 μΑ	μA
	current	$V_{CE} = 1200 \text{ V}; V_{GE} = 0 \text{ V};$ $T_j = 175 \text{ °C}$		-	-	10	mA
g _{fs}	Transconductance	V _{CE} = 20 V; I _C = 75 A		-	60	-	S
Dynamic	characteristics			,		,	'
C _{ies}	Input capacitance	$V_{CE} = 30 \text{ V}; V_{GE} = 0 \text{ V}; f = 1 \text{ MHz};$		-	17371	-	pF
C _{oes}	Output capacitance	T _j = 25 °C		-	151	-	pF
C _{res}	Reverse transfer capacitance			-	142	-	pF
Q_{G}	Gate charge	$V_{CC} = 960 \text{ V}; I_C = 75 \text{ A}; V_{GE} = 15 \text{ V};$ $T_j = 25 \text{ °C}$		-	745	-	nC

11. Switching Characteristics

Table 8. Switching Characteristics, Inductive Load

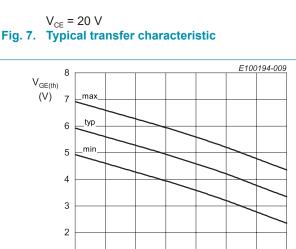
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
IGBT cha	racteristics						'
$t_{d(on)}$	Turn-on delay time	T _j = 25 °C;		-	71	-	nS
t _r	Rise time	$V_{CC} = 600 \text{ V}; I_C = 75 \text{ A};$ $V_{GE} = 15 \text{ V} / 0 \text{ V};$		-	65	-	nS
$t_{\text{d(off)}}$	Turn-off delay time	$R_G = 3.6 \Omega$		-	350	-	nS
t _f	Fall time			-	36	-	nS
E _{on}	Turn-on energy			-	5.1	-	mJ
E _{off}	Turn-off energy			-	1.95	-	mJ
E _{ts}	Total switching energy			-	7.05	-	mJ
t _{d(on)}	Turn-on delay time	T _j = 175 °C;		-	66	-	nS
t _r	Rise time	$V_{CC} = 600 \text{ V}; I_C = 75 \text{ A};$ $V_{GE} = 15 \text{ V} / 0 \text{ V};$		-	57	-	nS
$t_{d(off)}$	Turn-off delay time	$R_G = 3.6 \Omega$		-	430	-	nS
t _f	Fall time			-	81	-	nS
E _{on}	Turn-on energy			-	7.6	-	mJ
E _{off}	Turn-off energy			-	3.2	-	mJ
E _{ts}	Total switching energy			-	10.8	-	mJ
Diode cha	aracteristics					1	
t _{rr}	Reverse recovery time	T _j = 25 °C;		-	140	-	nS
Q _r	Reverse recovery charge	$V_R = 600 \text{ V}; I_F = 75 \text{ A};$ $dI_F/dt = 900 \text{A/us}$		-	1840	-	nC
I _{RM}	Reverse recovery peak current			-	29	-	Α
t _{rr}	Reverse recovery time	T _j = 175 °C;		-	322	-	nS
Q _r	Reverse recovery charge	$V_R = 600 \text{ V}; I_F = 75 \text{ A};$ $dI_F/dt = 900 \text{A/us}$		-	6900	-	nC
I _{RM}	Reverse recovery peak current	F		-	49	-	А





0

0



 $I_{c} = 750 \, \mu A$ Fig. 9. Gate-emitter threshold voltage as a function of junction temperature

75

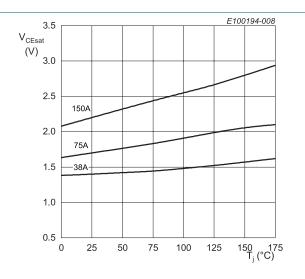
100

125

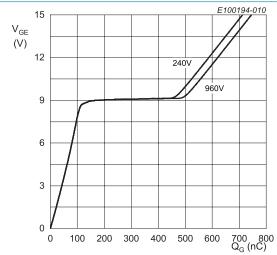
150 175 T_i (°C)

50

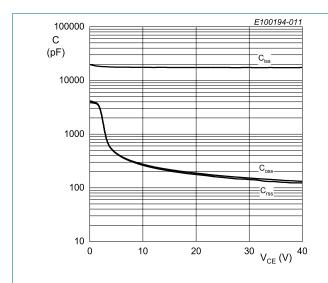
25



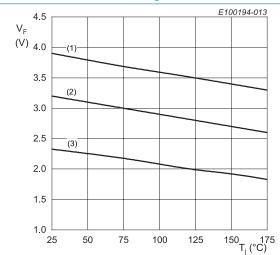
 $V_{GE} = 15 \text{ V}$ Fig. 8. Typical collector-emitter saturation voltage as a function of junction temperature



 $I_{c} = 75 A$ Fig. 10. Typical gate charge



 $\label{eq:VGE} V_{GE} = 0 \ V; \ f = 1 \ MHz$ Fig. 11. Typical capacitance as a function of collector-emitter voltage



(1) $I_F = 150 A$

(2) $I_F = 75 A$

(3) $I_F = 38 A$

Fig. 13. Typical diode forward voltage as a function of junction temperature

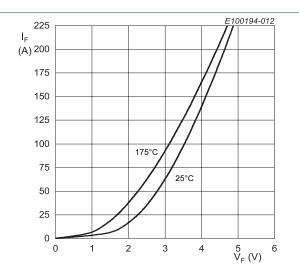
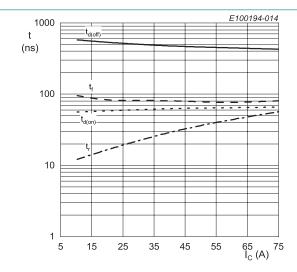
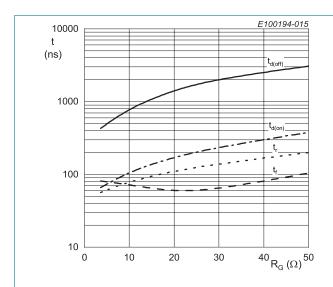


Fig. 12. Typical diode forward current as a function of forward voltage



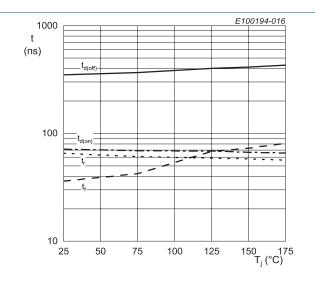
 R_{g} = 3.6 $\Omega;$ V_{GE} = 15V/0V; T_{j} = 175 °C; V_{CE} = 600 V; inductive load

Fig. 14. Typical switching times as a function of collector current



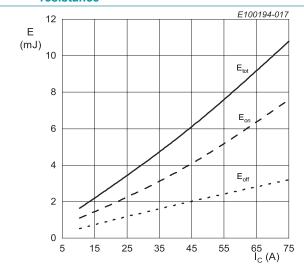
 I_C = 75 A; V_{GE} = 15V/0V; T_j = 175 °C; V_{CE} = 600 V; inductive load

Fig. 15. Typical switching times as a function of gate resistance



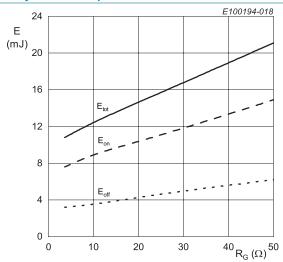
 I_{C} = 75 A; V_{GE} = 15V/0V; R_{g} = 3.6 Ω ; V_{CE} = 600 V; inductive load

Fig. 16. Typical switching times as a function of junction temperature



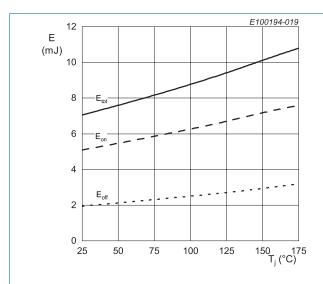
 R_g = 3.6 Ω ; V_{GE} = 15V/0V; T_j = 175 °C; V_{CE} = 600 V; inductive load

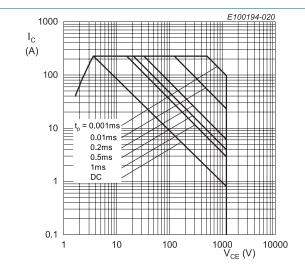
Fig. 17. Typical switching energy losses as a function of collector current



 I_{C} = 75 A; V_{GE} = 15V/0V; T_{j} = 175 °C; V_{CE} = 600 V; inductive load

Fig. 18. Typical switching energy losses as a function of gate resistance





 I_{C} = 75 A; V_{GE} = 15V/0V; R_{g} = 3.6 Ω; V_{CE} = 600 V; inductive load

Fig. 20. Forward bias safe operating area

Fig. 19. Typical switching energy losses as a function of junction temperature

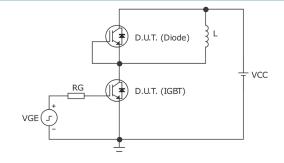


Fig. 21. Test circuit for inductive load switching

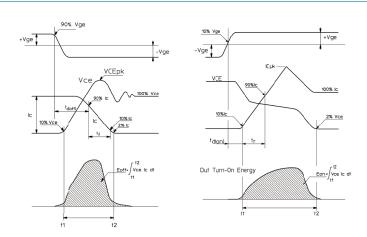
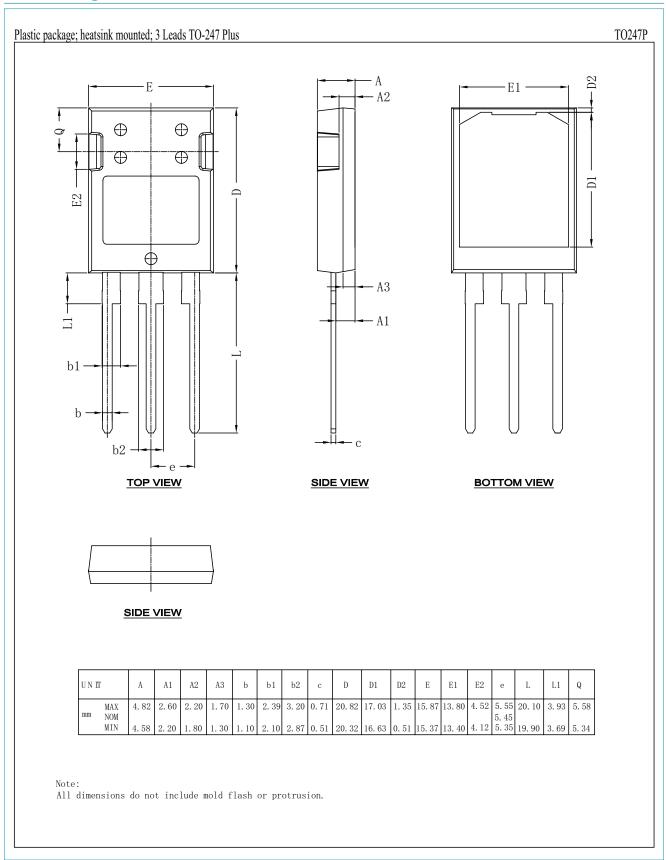


Fig. 22. Definition of switching times and losses

12. Package outline



13. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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14. Contents

1. General description	1
2. Features and benefits	1
3. Applications	1
4. Quick reference data	1
5. Pinning information	2
6. Ordering information	2
7. Marking	2
8. Limiting values	3
9. Thermal characteristics	4
10. Characteristics	5
11. Switching Characteristics	6
12. Package outline	12
13. Legal information	13
14 Contents	15

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